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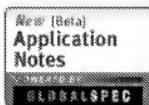
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Prabhakar, B.; Gupta, P.; Boyd, S.;
Information Theory and Networking Workshop, 1999
27 June-1 July 1999 Page(s):45
Digital Object Identifier 10.1109/ITNW.1999.814355
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☐ 2. **Near-optimal routing lookups with bounded worst case performance**
Gupta, P.; Prabhakar, B.; Boyd, S.;
INFOCOM 2000. Nineteenth Annual Joint Conference of the IEEE Computer Societies. Proceedings. IEEE
Volume 3, 26-30 March 2000 Page(s):1184 - 1192 vol.3
Digital Object Identifier 10.1109/INFCOM.2000.832490
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☐ 3. **Efficient binary search for IP address lookup**
Changhoon Yim; Bomi Lee; Hyesook Lim;
Communications Letters, IEEE
Volume 9, Issue 7, July 2005 Page(s):652 - 654
Digital Object Identifier 10.1109/LCOMM.2005.1461694
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